10/594683 IAP2 Rec'd PCT/PTO 28 SEP 2006

PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of

Docket No: Q80899

Takashi UDAGAWA

Appln. No.: National Stage of PCT/JP2005/006534

Confirmation No.: Unknown Group Art Unit: Unknown

Filed: September 28, 2006 Examiner: Unknown

For: COMPOUND SEMICONDUCTOR DEVICE, PRODUCTION METHOD OF

COMPOUND SEMICONDUCTOR DEVICE AND DIODE

<u>INFORMATION DISCLOSURE STATEMENT</u> <u>UNDER 37 C.F.R. §§ 1.97 and 1.98</u>

MAIL STOP AMENDMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

In accordance with the duty of disclosure under 37 C.F.R. § 1.56, Applicant hereby notifies the U.S. Patent and Trademark Office of the documents which are listed on the attached PTO/SB/08 A & B (modified) form and/or listed herein and which the Examiner may deem material to patentability of the claims of the above-identified application.

One copy of each of the listed documents is submitted herewith, except for the following: U.S. patents and/or U.S. patent publications; and co-pending non-provisional U.S. applications filed after June 30, 2003.

The present Information Disclosure Statement is being filed: (1) No later than three months from the application's filing date; (2) Before the mailing date of the first Office Action on the merits (whichever is later); or (3) Before the mailing date of the first Office Action after

INFORMATION DISCLOSURE STATEMENT

Appln. No.: National Stage of PCT/JP2005/006534

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filing a request for continued examination (RCE) under §1.114, and therefore, no Statement under 37 C.F.R. § 1.97(e) or fee under 37 C.F.R. § 1.17(p) is required.

In compliance with the concise explanation requirement under 37 C.F.R. § 1.98(a)(3) for foreign language documents, Applicant encloses herewith a copy of a Communication from a foreign patent office in a counterpart application citing such documents (International Search Report for PCT/JP2005/006534 and Written Opinion of the International Searching Authority dated June 21, 2005), together with an English-language version (if not already included) of at least that portion of the Communication indicating the degree of relevance found by the foreign patent office. Also, in compliance with the concise explanation requirement under 37 C.F.R. § 1.98(a)(3) for foreign language documents, U.S. Patent No. 5,228,044, U.S. Patent No. 5,387,804, U.S. Patent No. 5,063,421, U.S. Patent No. 5,076,860, U.S. Patent No. 5,042,043, U.S. Patent No. 5,005,057, and EP 1 109 208 correspond to JP 4-84486, JP 2-177577, JP 2-46779, JP 2-275682, JP 2-288388, JP 2-288371, and JP 2001-176804, respectively.

The submission of the listed documents is not intended as an admission that any such document constitutes prior art against the claims of the present application. Applicant does not waive any right to take any action that would be appropriate to antedate or otherwise remove any listed document as a competent reference against the claims of the present application.

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The USPTO is directed and authorized to charge all required fees, except for the Issue Fee and the Publication Fee, to Deposit Account No. 19-4880. Please also credit any overpayments to said Deposit Account.

Respectfully submitted,

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WASHINGTON OFFICE 23373
CUSTOMER NUMBER

Date: September 28, 2006

Substitute for Form 1449 A & B/PTO National Stage of Application Number PCT/JP2005/006534 **INFORMATION DISCLOSURE** Confirmation Number Unknown STATEMENT BY APPLICANT Filing Date September 28, 2006 First Named Inventor Takashi UDAGAWA (use as many sheets as necessary) Art Unit Unknown Examiner Name Sheet 1 of 2 Attorney Docket Number Q80899

U.S. PATENT DOCUMENTS							
Examiner Initials*	Cite	Document N	umber	Publication Date MM-DD-YYYY			
	No.1	Number	Kind Code ² (if known)		Name of Patentee or Applicant of Cited Document		
		US 2001/0012678	Al	08/09/2001	SATORU TANAKA, ET AL		
		US 5,228,044	Α	07/13/1993	YASUO OHBA		
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		US 5,005,057		04/02/1991	TOSHIHIDE IZUMIYA, ET AL		
		US					
		US					

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Examiner Initials*	Cite No.1	Foreign Patent Document			Publication Date	Name of Patentee or		
		Country Code ³	Number ⁴	Kind Code ⁵ (if known)	MM-DD-YYYY	Applicant of Cited Document	Translation ⁶	
		JP	2004-47847	Α	02/12/2004	SHOWA DENKO K.K.	Abstract	
		JP	2003-303779	Α	10/24/2003	SHOWA DENKO K.K.	Abstract	
		EP	1 109 208	A2	06/20/2001	RIKEN		
		JP	2001-176804	Α	06/29/2001		Abstract	
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		JР	2003-229599	Α	08/15/2003		Abstract	
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		JР	4-84486	Α	03/17/1992		Abstract	
		JP	55-3834	B2	01/26/1980		Abstract	

NON PATENT LITERATURE DOCUMENTS								
Examiner Initials*	Cite No. ¹	and a sum of the section (in Chi 1176 BB1 1186), the of the article (when appropriate), the of the item (book, magazine,						
		T. L. CHU, ET AL, "CRYSTAL AND EPITAXIAL LAYERS OF BORON PHOSPHIDE", JOURNAL OF APPLIED PHYSICS, VOL. 42, NO. 1, January 1991, PAGES 420-424						
		IWAO TERAMOTO, "INTRODUCTION OF SEMICONDUCTOR DEVICE", BAIHUKAN, March 30, 1995, PAGE 28						
		SIR PETER HIRSCH, ET AL, "ELECTRON MICROSCOPY OF THIN CRYSTAL", (USA), KRIEGER PUB. COM., 1977, PAGES 141-148						

Examiner Signature	<u>L</u>	Date Considered	

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

¹Applicant's unique citation designation number (optional). ²See Kind Codes of USPTO Patent Documents at www.uspto.gov, MPEP 901.04 or follow the hyperlink from the title of the document to the intranet. ³ Enter Office that issued the document, by the two-letter code (WIPO Standard ST. 3). ⁴For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. ⁶ Applicant is to indicate here if English language Translation is attached.

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MODIFIED PTO/SB/08 A & B (08-03)

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				Complete if Known			
Substitute for Form 1449 A &	B/PTO		•		National Stage of		
				Application Number	PCT/JP2005/006534		
<u>INFORM</u> A	ATION DISCI	<u>LOS</u>	URE	Confirmation Number	Unknown		
<u>STATEM</u>	ENT BY APP	LIC.	ANT	Filing Date	September 28, 2006		
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				Examiner Name			
Sheet	2	of	2	Attorney Docket Number	Q80899		

U.S. PATENT DOCUMENTS							
Examiner Initials*	Cita	Document	Number	Publication Date			
	Cite No.1	Number	Kind Code ² (if known)	MM-DD-YYYY	Name of Patentee or Applicant of Cited Document		
		US			-		
	-	US					
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FOREIGN PATENT DOCUMENTS							
Examiner Initials*	Cite No.1	Foreign Patent Document			Publication Date	Name of Patentee or	
		Country Code ³	Number ⁴	Kind Code ⁵ (if known)	MM-DD-YYYY	Applicant of Cited Document	Translation ⁶
		JP	60-207332	A	10/18/1985	MATSUSHITA ELECTRONIC IND. CO. LTD.	Abstract
		JP	2-177577	A	07/10/1990		Abstract
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		JР	2-288371	A	11/28/1990		Abstract
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Examiner Initials*	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city, and/or country where published.			
		Y. KUMASIRO, ET AL, "PREPARATION AND ELECTRICAL PROPERTIES OF BORON AND BORON PHOSPHIDE FILMS OBTAINED BY GAS SOURCE MOLECULAR BEAM DEPOSITION", JOURNAL OF SOLID STATE CHEMISTRY, VOL. 133, 1997, PAGES 269-272			
		YUKINOBU KUMASHIRO, "ELECTRIC REFRACTORY MATERIALS", (USA), MARCEL DEKKER INC., 2000, PAGES 409-411			

Examiner Signature	Date Considered	

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